RURH3020CC



Data Sheet

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30A, 200V Ultrafast Dual Diode

The RURH3020CC is an ultrafast dual diode (t_{rr} < 45ns) with soft recovery characteristics. It has a low forward voltage drop and is of planar, silicon nitride passivated, ion-implanted, epitaxial construction.

This device is intended for use as an energy steering/ clamping diode and rectifier in a variety of switching power supplies and other power switching applications. Its low stored charge and ultrafast recovery with soft recovery characteristics minimize ringing and electrical noise in many power switching circuits thus reducing power loss in the switching transistor.

Formerly developmental type TA09645.

Ordering Information

PART NUMBER	PACKAGE	BRAND
RURH3020CC	TO-218AC	RURH3020C

NOTE: When ordering, use the entire part number.

Symbol



Features

- Ultrafast with Soft Recovery<45ns
- Operating Temperature......175^oC
- Avalanche Energy Rated
- Planar Construction

Applications

- Switching Power Supply
- Power Switching Circuits
- General Purpose

Packaging





Absolute Maximum Ratings (Per Leg) T_C = 25°C, Unless Otherwise Specified

	RURH3020CC	UNITS
Peak Repetitive Reverse VoltageV _{RRM}	200	V
Working Peak Reverse VoltageV _{RWM}	200	V
DC Blocking Voltage	200	V
Average Rectified Forward Current	30	A
Repetitive Peak Surge CurrentIFRM (Square Wave 20kHz)	70	A
Nonrepetitive Peak Surge Current IFSM (Halfwave 1 Phase 60Hz)	325	A
Maximum Power Dissipation	125	W
Avalanche Energy (See Figures 7 and 8)E _{AVL}	20	mJ
Operating and Storage Temperature	-55 to 175	°C

SYMBOL	TEST CONDITION	MIN	ТҮР	МАХ	UNITS
V _F	I _F = 30A	-	-	1.0	V
	I _F = 30A, T _C = 150 ^o C	-	-	0.85	V
I _R	V _R = 200V	-	-	250	μΑ
	$V_{\rm R} = 200 V, T_{\rm C} = 150^{\rm o} {\rm C}$	-	-	1.0	mA
t _{rr}	$I_F = 1A$, $dI_F/dt = 100A/\mu s$	-	-	45	ns
	I _F = 30A, dI _F /dt = 100A/μs	-	-	50	ns
t _a	I _F = 30A, dI _F /dt = 100A/μs	-	28	-	ns
t _b	I _F = 30A, dI _F /dt = 100A/μs	-	20	-	ns
R _{θJC}		-	-	1.2	°C/W

Electrical Specifications (Per Leg) $T_C = 25^{\circ}C$, Unless Otherwise Specified

DEFINITIONS

 V_F = Instantaneous forward voltage (pw = 300 µs, D = 2%).

 I_R = Instantaneous reverse current.

 t_{rr} = Reverse recovery time at dI_F/dt = 100A/µs (See Figure 6), summation of t_a + t_b .

 t_a = Time to reach peak reverse current at dI_F/dt = 100A/µs (See Figure 6).

tb = Time from peak IRM to projected zero crossing of IRM based on a straight line from peak IRM through 25% of IRM (See Figure 6).

 $R_{\theta JC}$ = Thermal resistance junction to case.

pw = pulse width.

D = duty cycle.

Typical Performance Curves



FIGURE 1. FORWARD CURRENT vs FORWARD VOLTAGE



FIGURE 2. REVERSE CURRENT vs REVERSE VOLTAGE

Typical Performance Curves



FIGURE 3. t_{rr}, t_a AND t_b CURVES vs FORWARD CURRENT

SENSE

DUT











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Test Circuits and Waveforms

 $\begin{array}{l} V_{GE} \text{ AMPLITUDE AND} \\ R_{G} \text{ CONTROL } dI_{F} / dt \\ t_{1 \text{ AND}} t_{2} \text{ CONTROL } I_{F} \end{array}$



R_G